

Day : Tuesday
Date: 6/15/2004


PALM INTRANET

Time: 08:53:06

Inventor Name Search Result

Your Search was:

Last Name = GHINOVKER

First Name = MARK

Application#	Patent#	Status	Date Filed	Title	Inventor Name 29
<u>60546546</u>	Not Issued	020	02/20/2004	APPARATUS AND METHODS FOR DETERMINING OVERLAY AND USES OF SAME	GHINOVKER, MARK
<u>60506281</u>	Not Issued	020	09/26/2003	STRUCTURES AND METHODS FOR OVERLAY METROLOGY	GHINOVKER, MARK
<u>60484627</u>	Not Issued	020	07/02/2003	APPARATUS AND METHODS FOR PROVIDING IN-CHIP MICROTARGETS FOR METROLOGY OR INSPECTION	GHINOVKER, MARK
<u>60456681</u>	Not Issued	020	03/19/2003	USE OF OVERLAY DIAGNOSTICS FOR ENHANCED AUTOMATIC PROCESS CONTROL	GHINOVKER, MARK
<u>60419786</u>	Not Issued	020	10/17/2002	OVERLAY METROLOGY	GHINOVKER, MARK
<u>60395847</u>	Not Issued	159	07/11/2002	USE OF OVERLAY DIAGNOSTICS FOR ENHANCED AUTOMATIC PROCESS CONTROL	GHINOVKER, MARK
<u>60386285</u>	Not Issued	159	06/05/2002	USE OF OVERLAY DIAGNOSTICS FOR ENHANCED AUTOMATIC PROCESS CONTROL	GHINOVKER, MARK
<u>60357390</u>	Not Issued	159	02/15/2002	OVERLAY METROLOGY	GHINOVKER, MARK
<u>60301763</u>	Not Issued	159	06/27/2001	OVERLAY MARKS, METHOD OF OVERLAY MARK DESIGNED AND METHODS OF OVERLAY MEASUREMENTS	GHINOVKER, MARK

<u>60301613</u>	Not Issued	159	06/27/2001	OVERLAY MARKS, METHOD OF OVERLAY MARK DESIGNED AND METHODS OF OVERLAY MEASUREMENTS	GHINOVKER, MARK
<u>60301591</u>	Not Issued	159	06/27/2001	OVERLAY MARKS, METHOD OF OVERLAY MARK DESIGNED AND METHODS OF OVERLAY MEASUREMENTS	GHINOVKER, MARK
<u>60301484</u>	Not Issued	159	06/27/2001	OVERLAY MARKS, METHOD OF OVERLAY MARK DESIGNED AND METHODS OF OVERLAY MEASUREMENTS	GHINOVKER, MARK
<u>10785821</u>	Not Issued	019	02/23/2004	APPARATUS AND METHODS FOR DETECTING OVERLAY ERRORS USING SCATTEROMETRY	GHINOVKER, MARK
<u>10785732</u>	Not Issued	019	02/23/2004	APPARATUS AND METHODS FOR DETECTING OVERLAY ERRORS USING SCATTEROMETRY	GHINOVKER, MARK
<u>10785731</u>	Not Issued	019	02/23/2004	APPARATUS AND METHODS FOR DETECTING OVERLAY ERRORS USING SCATTEROMETRY	GHINOVKER, MARK
<u>10785723</u>	Not Issued	019	02/23/2004	APPARATUS AND METHODS FOR DETECTING OVERLAY ERRORS USING SCATTEROMETRY	GHINOVKER, MARK
<u>10785430</u>	Not Issued	019	02/23/2004	APPARATUS AND METHODS FOR DETECTING OVERLAY ERRORS USING SCATTEROMETRY	GHINOVKER, MARK
<u>10785396</u>	Not Issued	019	02/23/2004	APPARATUS AND METHODS FOR DETECTING OVERLAY ERRORS USING SCATTEROMETRY	GHINOVKER, MARK
<u>10785395</u>	Not Issued	019	02/23/2004	APPARATUS AND METHODS FOR DETECTING OVERLAY ERRORS	GHINOVKER, MARK
<u>10729838</u>	Not Issued	018	12/05/2003	APPARATUS AND METHOD FOR DETECTING OVERLAY ERRORS USING SCATTEROMETRY	GHINOVKER, MARK

<u>10438963</u>	Not Issued	030	05/14/2003	USE OF OVERLAY DIAGNOSTICS FOR ENHANCED AUTOMATIC PROCESS CONTROL	GHINOVKER, MARK
<u>10438962</u>	Not Issued	030	05/14/2003	USE OF OVERLAY DIAGNOSTICS FOR ENHANCED AUTOMATIC PROCESS CONTROL	GHINOVKER, MARK
<u>10423827</u>	Not Issued	030	04/25/2003	METHOD AND MARK FOR METROLOGY OF PHASE ERRORS ON PHASE SHIFT MASKS	GHINOVKER, MARK
<u>10367124</u>	Not Issued	020	02/13/2003	OVERLAY METROLOGY AND CONTROL METHOD	GHINOVKER, MARK
<u>10186324</u>	Not Issued	030	06/26/2002	OVERLAY MARKS, METHODS OF OVERLAY MARK DESIGN AND METHODS OF OVERLAY MEASUREMENTS	GHINOVKER, MARK
<u>10185737</u>	Not Issued	071	06/26/2002	OVERLAY MARKS, METHODS OF OVERLAY MARK DESIGN AND METHODS OF OVERLAY MEASUREMENTS	GHINOVKER, MARK
<u>10184026</u>	Not Issued	030	06/26/2002	OVERLAY MARKS, METHODS OF OVERLAY MARK DESIGN AND METHODS OF OVERLAY MEASUREMENTS	GHINOVKER, MARK
<u>10184013</u>	Not Issued	030	06/26/2002	OVERLAY MARKS, METHODS OF OVERLAY MARK DESIGN AND METHODS OF OVERLAY MEASUREMENTS	GHINOVKER, MARK
<u>09894987</u>	Not Issued	030	06/27/2001	OVERLAY MARKS, METHODS OF OVERLAY MARK DESIGN AND METHODS OF OVERLAY MEASUREMENTS	GHINOVKER, MARK

Inventor Search Completed: No Records to Display.

Search Another: Inventor

Last Name	First Name
<input type="text" value="GHINOVKER"/>	<input type="text" value="MARK"/>

To go back use Back button on your browser toolbar.

Back to [PALM](#) | [ASSIGNMENT](#) | [OASIS](#) | Home page